

<b>Notice of References Cited</b>	Application/Control No. 10/765,918	Applicant(s)/Patent Under Reexamination NONAKA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,881,349	03-1999	Nanataki et al.	399/328
	B	US-5,794,096	08-1998	Okabayashi, Eiji	399/33
	C	US-6,438,335	08-2002	Kinouchi et al.	399/67
	D	US-2002/0076239 A	06-2002	Inoue, Ryo	399/167
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10301442 A	11-1998	Japan	HAYASHIZAKI, MINORU	G03G 15/20
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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